Issue Classification

Application/Control No. 10/016,323	**Applicant(s)/Patent under Reexamination** HEI ET AL.
Examiner David M. Naff	**Art Unit** 1651

ISSUE CLASSIFICATION

ORIGINAL

CLASS	SUBCLASS
435	2

CROSS REFERENCE(S)

CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)			
424	529			
435	238	283.1		
530	412	413	415	

INTERNATIONAL CLASSIFICATION

A	0	1	N	1/02
A	6	1	K	35/14
C	1	2	N	7/06
C	1	2	M	1/00
C	0	7	K	1/00

(Assistant Examiner) (Date)

(Legal Instruments Examiner) (Date)

David M. Naff 3/21/05 (Primary Examiner) (Date)

Total Claims Allowed: 45

O.G. Print Claim(s)	O.G. Print Fig.
1	None

☐ Claims renumbered in the same order as presented by applicant ☐ CPA ☐ T.D. ☐ R.1.47

Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original
	1		31		61	38	91		121		151		181
	2		32		62	39	92		122		152		182
	3		33		63	40	93		123		153		183
	4		34		64	41	94		124		154		184
	5		35	3	65	42	95		125		155		185
	6		36	4	66	43	96		126		156		186
	7		37		~~67~~	44	97		127		157		187
	8		38	5	68		98		128		158		188
	9		39	6	69		99		129		159		189
	10		40	7	70		100		130		160		190
	11		41	8	71		101		131		161		191
	12		42	9	72		102		132		162		192
	13		43	10	73		103		133		163		193
	14		44	11	74	19	104		134		164		194
	15		45	12	75	20	105		135		165		195
	16		46	13	76	21	106		136		166		196
	17		47	14	77	22	107		137		167		197
	18		48	15	78	23	108		138		168		198
	19		49	16	79	24	109		139		169		199
	20		50	17	80	25	110		140		170		200
	21		51	18	81	26	111		141		171		201
	22		52	29	82	27	112		142		172		202
	23		53	30	83	28	113		143		173		203
	24		54	35	84	45	114		144		174		204
	25		55	36	85		115		145		175		205
	26		56	37	86		116		146		176		206
	27		57	31	87		117		147		177		207
	28	1	58	32	88		118		148		178		208
	29		~~59~~	33	89		119		149		179		209
	30	2	60	34	90		120		150		180		210

U.S. Patent and Trademark Office